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Test	t Report
Sample Name:	Discrete components LQH32PN100MNCL
Manufacturer: Customer:	MURATA
	Olab

Chuangxin Online Test Center Laboratory

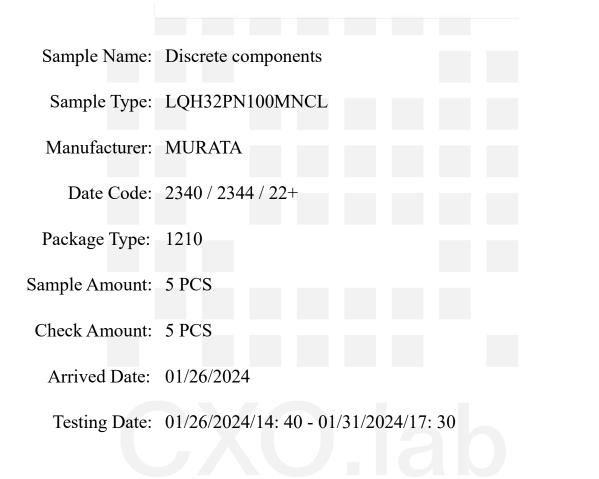
February 01, 2024



# **Test Report**

Customer:

Customer Address:



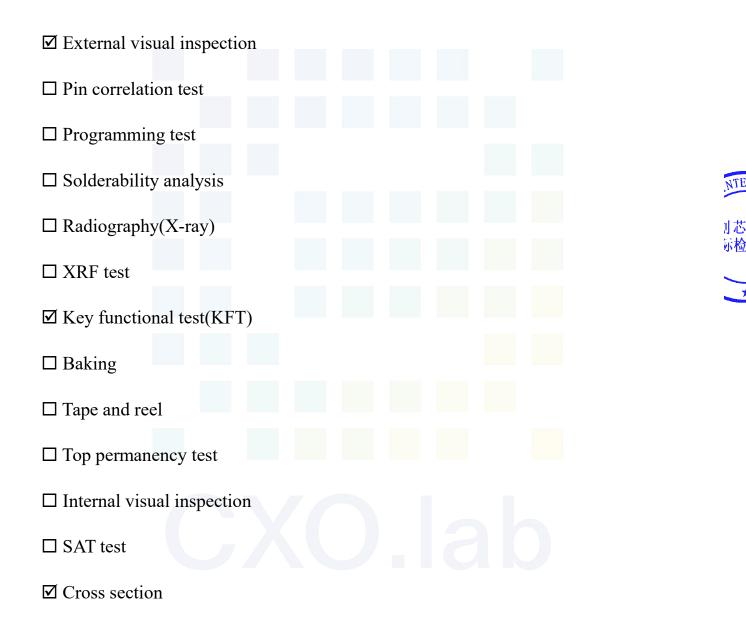




Tested	by	·
Inspected	l by	
Approved	d by	<b>_</b>



# **Test Item**



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# **Methods & Equipment**

### 1.1 Test standard:

- AS6081A-2023
- GJB 4027A-2006

#### **1.2 Optical microscope:**

• Equipment spec:

Optical microscope: SEZ-260 X7-X45(Due date: 7/18/2024)

#### 1.3 Digital caliper:

• Equipment spec:

Digital caliper: (0~150) mm(Due date: 7/18/2024)

### **1.4 Functional test equipment:**

• Equipment spec:

Precision LCR meter: TH2838A(Due date: 7/18/2024)

DC resistance tester: ZX5512F(Due date: 7/18/2024)

### **1.5 Metallographic grinding and polishing machine:**

• Equipment spec:

Metallographic grinding and polishing machine: JMP-2AW(Due date: 7/18/2024)



### **1.6 Product datasheet:**

• 《MURATA LQH32PN100MNCL》:

https://search.murata.co.jp/Ceramy/image/img/P02/JELF243A-0091.pdf







# **Analysis Summary**

### **External visual inspection:**

### Applicable standard: AS6081A-2023

External visual inspection on 5 PCS samples(2 PCS D/C 2340, 1 PCS of D/C 22+

and 2 PCS of D/C 2344). No secondary coating, sanding marks, crack or chips were

observed on all inspected. No abnormalities were found during comparison.

Devices package and dimension matched to manufacturer's specification.

All devices passed the external visual inspection.

- (1) Specification dimension:
- L:  $3.20 \pm 0.30$  mm
- W:  $2.50 \pm 0.20$  mm
- H:  $1.55 \pm 0.15$  mm
- (2) Measurement dimension(D/C 2340):
- L: 3.24 mm
- W: 2.55 mm
- H: 1.63 mm



- (3) Measurement dimension(D/C 22+):
- L: 3.24 mm
- W: 2.56 mm
- H: 1.62 mm
- (4) Measurement dimension(D/C 2344):
- L: 3.24 mm
- W: 2.60 mm
- H: 1.62 mm

External visual criteria	Yes/No	Result
Mix-up	No	Pass
Top scratches	No	Pass
Bottom scratches	No	Pass
Chips	No	Pass
Residues	No	Pass
Indentation	No	Pass
Contamination	No	Pass
Cracks	No	Pass
Copper defect	No	Pass
Oxidization	No	Pass
Coplanarity	Yes	Pass





Sanding marks	No	Pass
Secondary coating	No	Pass
Top permanency test	N/A	N/A

# Key functional test(KFT) results:

Key functional test(KFT)	Results:		
Total quantity tested	5 PCS(2 PCS of D/C 2340, 1 PCS of D/C 22+ and 2 PCS of D/C 2344)		
Total quantity passed	5 PCS		
Total quantity failed	0 PCS		
Note	All devices passed the parameter test.		
Key functional test(KFT) results:			
Tested parameters	Results		
Inductance	Pass		
DC resistance	Pass		



### **Cross section:**

### Applicable standard: GJB 4027A-2006

The internal structure of the 2 PCS samples(1 PCS D/C 2340, 1 PCS of D/C

2344)was consistent in the slice test.

1. Golden sample(D/C 2340)	
End electrode copper wire diameter : 0.10 mm	
Internal winding coil diameter : 0.12 mm	
Internal medium thickness : 0.75 mm	NTE
Plastic sealing thickness : 0.37 mm	調査
	示检
2. Test sample(D/C 2344)	<b> </b>
End electrode copper wire diameter : 0.10 mm	
Internal winding coil diameter : 0.13 mm	
Internal medium thickness : 0.75 mm	
Plastic sealing thickness : 0.35 mm	

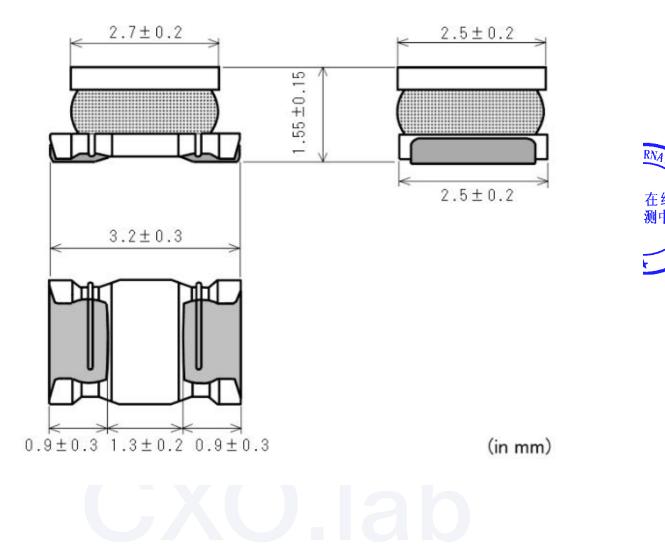
Summarize : Slice comparison reveals consistent structure between two pieces.



## **1. Device description:**

No device description was found.

## 2. Package dimension:

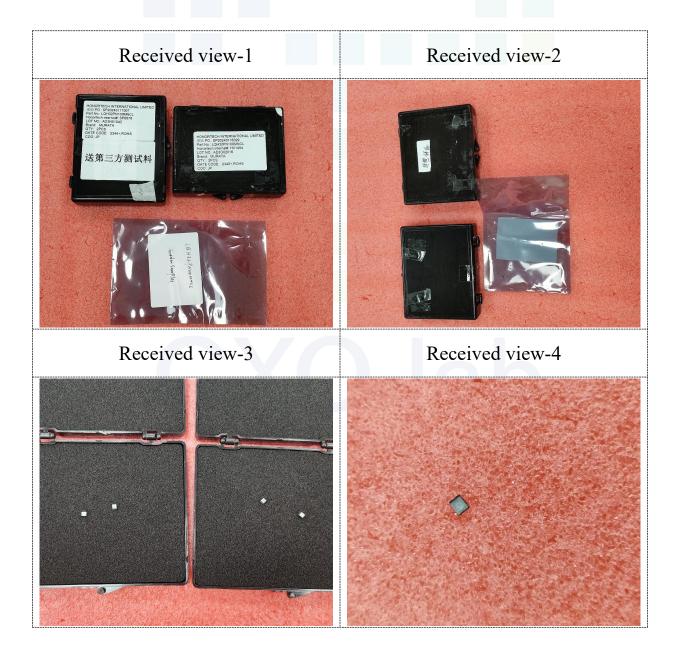


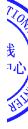


# **3. Receiving inspection:**

Gross Weight	96 g	Parts Total	5 PCS
Number of Boxes	N/A	Full Label	N/A
Package Type	Bulk	Moisture Protection	N/A
MSL	N/A	ESD Protection	Exist

Note: All devices contain 5 PCS samples.







Received view-5	Received view-6
HONORTECH INTERNATIONAL LIMITED	HONORTECH INTERNATIONAL LIMITED
采购 PO.: SP20240116029	采购 PO.: SP20240117007
Part No.: LQH32PN100MNCL	Part No.: LQH32PN100MNCL
Honortech internal#: HV1454	Honortech internal#: SP6578
LOT NO.: AD3O02016	LOT NO.: AD3N01042
Brand: MURATA	Brand: MURATA
QTY: 2PCS	QTY: 2PCS
DATE CODE: 2340+,ROHS	DATE CODE: 2344+,ROHS
COO: JP	COO: JP







### 4. External visual inspection:

Applicable standard: AS6081A-2023

Ambient temperature: 23.6 °C Relative humidity: 57.5 % RH

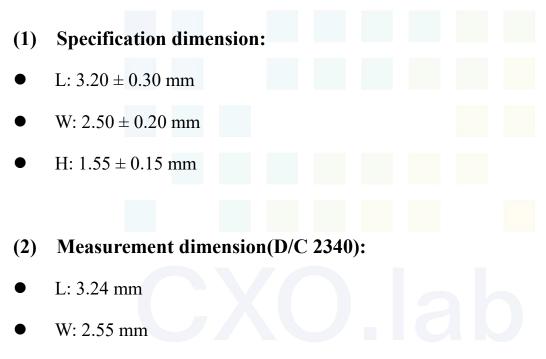
External visual inspection on 5 PCS samples(2 PCS D/C 2340, 1 PCS of D/C 22+

and 2 PCS of D/C 2344). No secondary coating, sanding marks, crack or chips were

observed on all inspected. No abnormalities were found during comparison.

Devices package and dimension matched to manufacturer's specification.

All devices passed the external visual inspection.



• H: 1.63 mm

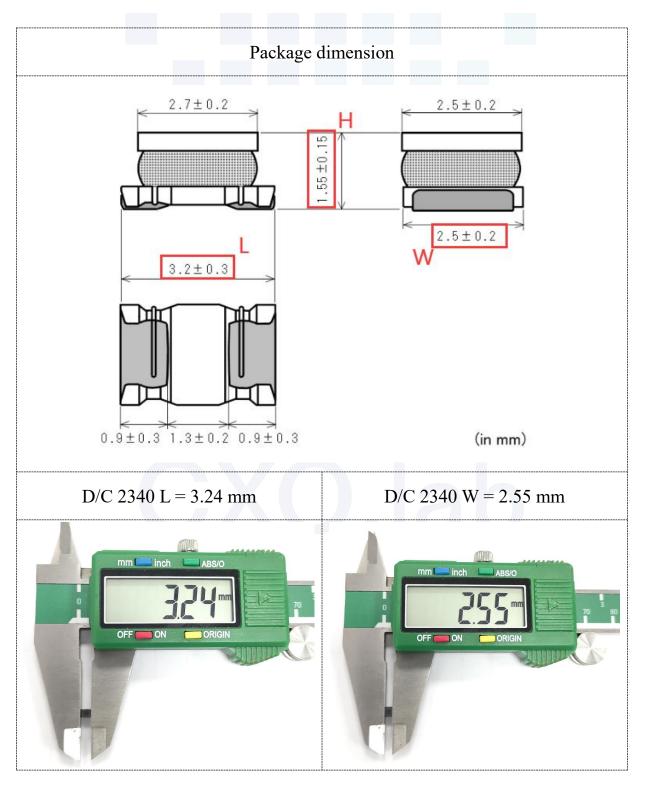
(3) Measurement dimension(D/C 22+):

- L: 3.24 mm
- W: 2.56 mm
- H: 1.62 mm

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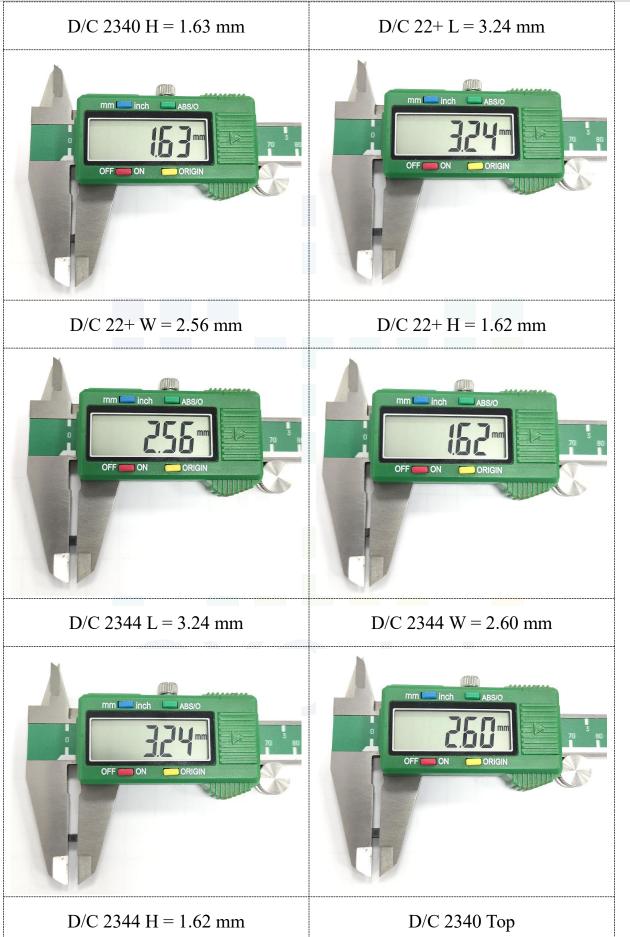
- (4) Measurement dimension(D/C 2344):
- L: 3.24 mm
- W: 2.60 mm
- H: 1.62 mm





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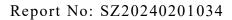


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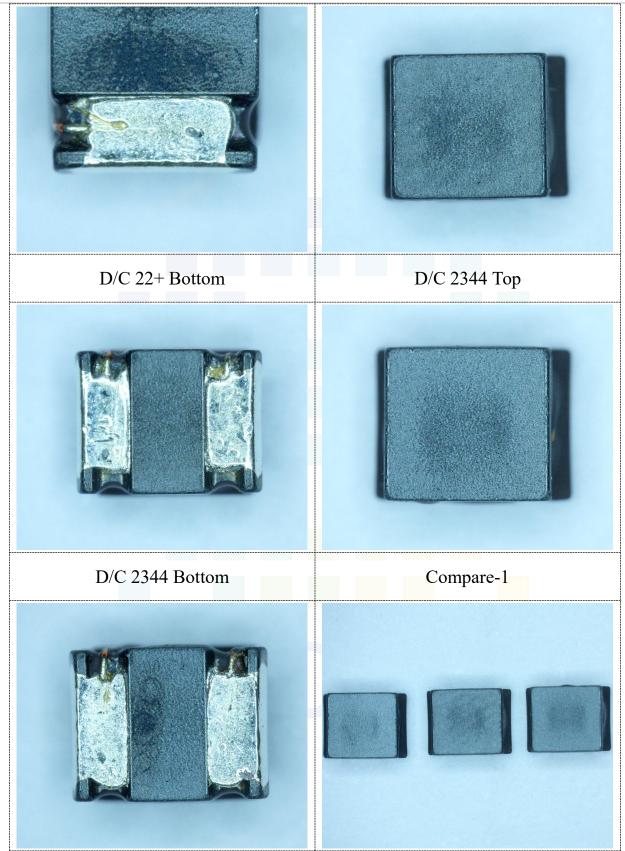
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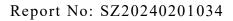








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Compare-2	Compare-3	





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## 5. Key functional test(KFT):

Applicable standard: AS6081A-2023

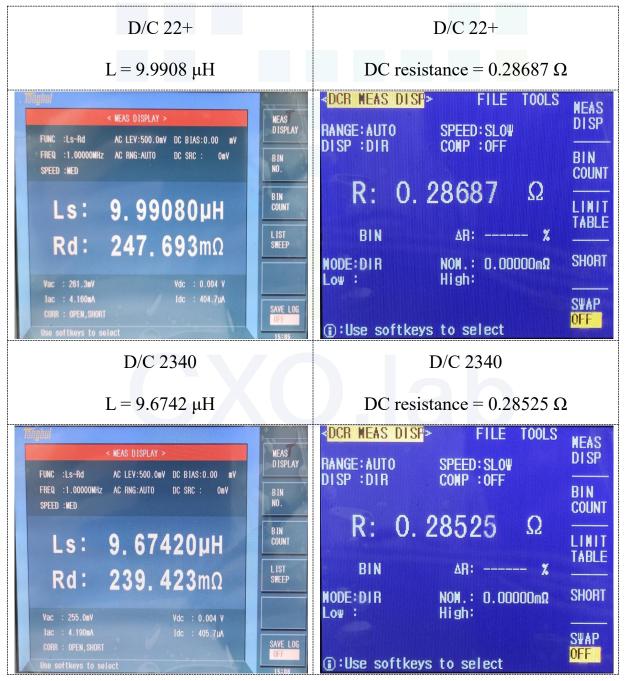
Ambient temperature: 24.2 °C Relative humidity: 56.8 % RH

Using Precision LCR meter and DC resistance tester verified the following

parameters:

-Inductance: L = 10  $\mu$ H ±20% (*a*) 1 MHz;

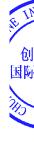
-DC resistance: 0.295  $\Omega \pm 20\%$ ;





D/C 2344			D/C 2344	
L = 10.	$L = 10.0803 \ \mu H$		esistance = $0.28257 \ \Omega$	
<pre> Keas displa Func :Ls-Rd</pre>	Omv     DC     BIAS:0.00     mv       DC     SRC     Omv     BIN       D803µH     LISI       278mΩ     Mu       Vdc     : 0.013 V       Idc     : 407.1µA	RANGE: AUTO DISP:DIR R: C BIN NODE:DIR Low :	SF>   FILE TOOLS   MEAS     SPEED: SLOW   DISF     COMP : OFF   BIN     COMP : OFF   BIN     COMP : OFF   BIN     AR:   COULD     AR:   X     NOM. :   0.00000mΩ     High:   SWAF     OFF   SWAF	
Pa	Parameter		DC resistance	
Sample	Sample		(mΩ)	
D/C 22+		9.9908	0.28687	
D/C 2340	A1	9.6742	0.28525	
D/C 2340	D/C 2340 A2		0.27945	
D/C 2344	B1	10.0803	0.28257	
D/C 2344	B2	10.0893	0.28426	

Key functional test(KFT)	Results:
Total quantity tested	5 PCS(2 PCS of D/C 2340, 1 PCS of D/C 22+ and 2 PCS of D/C 2344)
Total quantity passed	5 PCS
Total quantity failed	0 PCS
Note	All devices passed the parameter test.





## 6. Cross section:

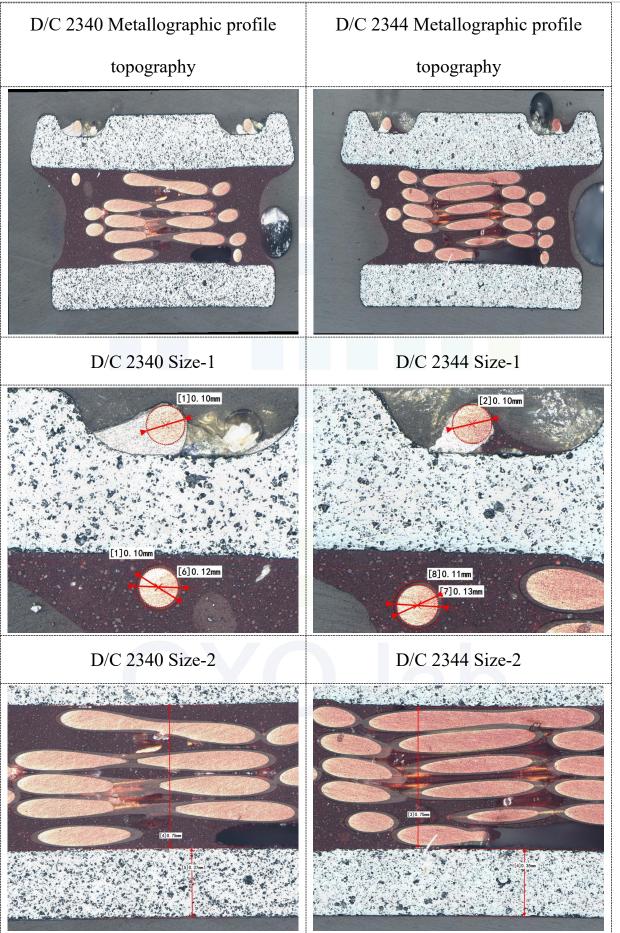
Applicable standard: AS6081-2012
Ambient temperature: 23.2 °C Relative humidity: 56.5 % RH
The internal structure of the 2 PCS samples(1 PCS D/C 2340, 1 PCS of D/C
2344)was consistent in the slice test.
3. Golden sample(D/C 2340)
End electrode copper wire diameter : 0.10 mm
Internal winding coil diameter : 0.12 mm
Internal medium thickness : 0.75 mm
Plastic sealing thickness: 0.37 mm 检测
4. Test sample(D/C 2344)
End electrode copper wire diameter : 0.10 mm
Internal winding coil diameter : 0.13 mm
Internal medium thickness : 0.75 mm
Plastic sealing thickness : 0.35 mm

Summarize : Slice comparison reveals consistent structure between two pieces.

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-End of Report-



# Disclaimer

1. The test report is invalid without the stamp of "company seal" and "cross-page seal".

2. The copy of the test report is invalid without the stamp of "company seal" and "cross-page seal".

**3.** The test report is invalid without the signatures of operator, supervisor and manager.

**4.** A modified or partial copy of the test report is invalid.

5. When there is disagreement with the test report, please submit the issue to us within 15 days from the date of receipt. Overdue information will not be accepted.

**6.** The test report is only reflective of the test results of testing samples, not of the quality of batch products.

7. The \* indicates subcontract test data.





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